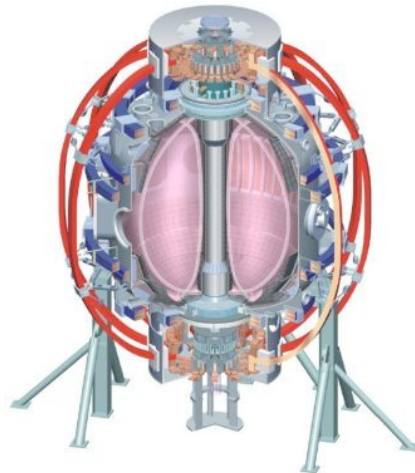


Investigation of a High-Energy Feature (HEF) Observed on Beam-injected Energetic Ion Spectra using the E||B Neutral Particle Analyzer on NSTX

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UCLA
UCSD
U Colorado
U Illinois
U Maryland
U Rochester
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S. S. Medley

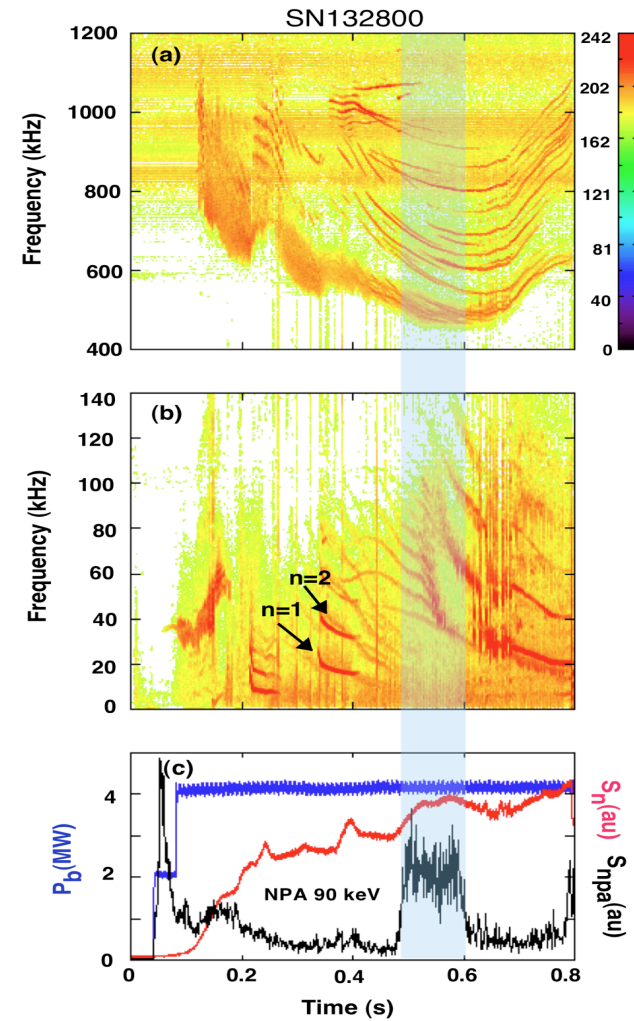
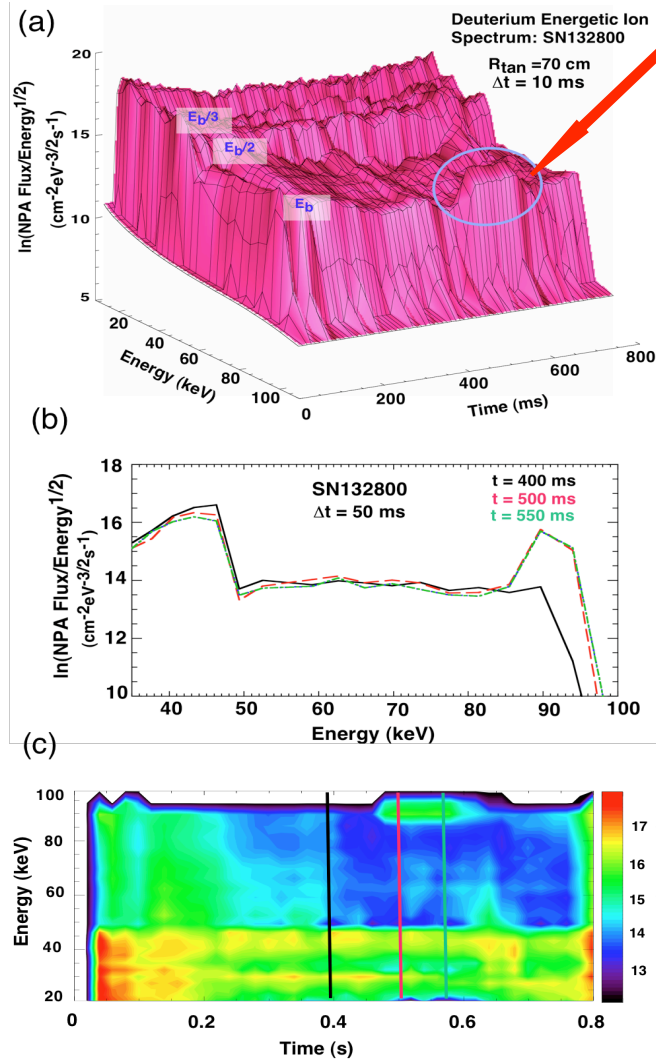
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Illustration of a **High-Energy Feature (HEF)** at $t \sim 0.5-0.6$ s

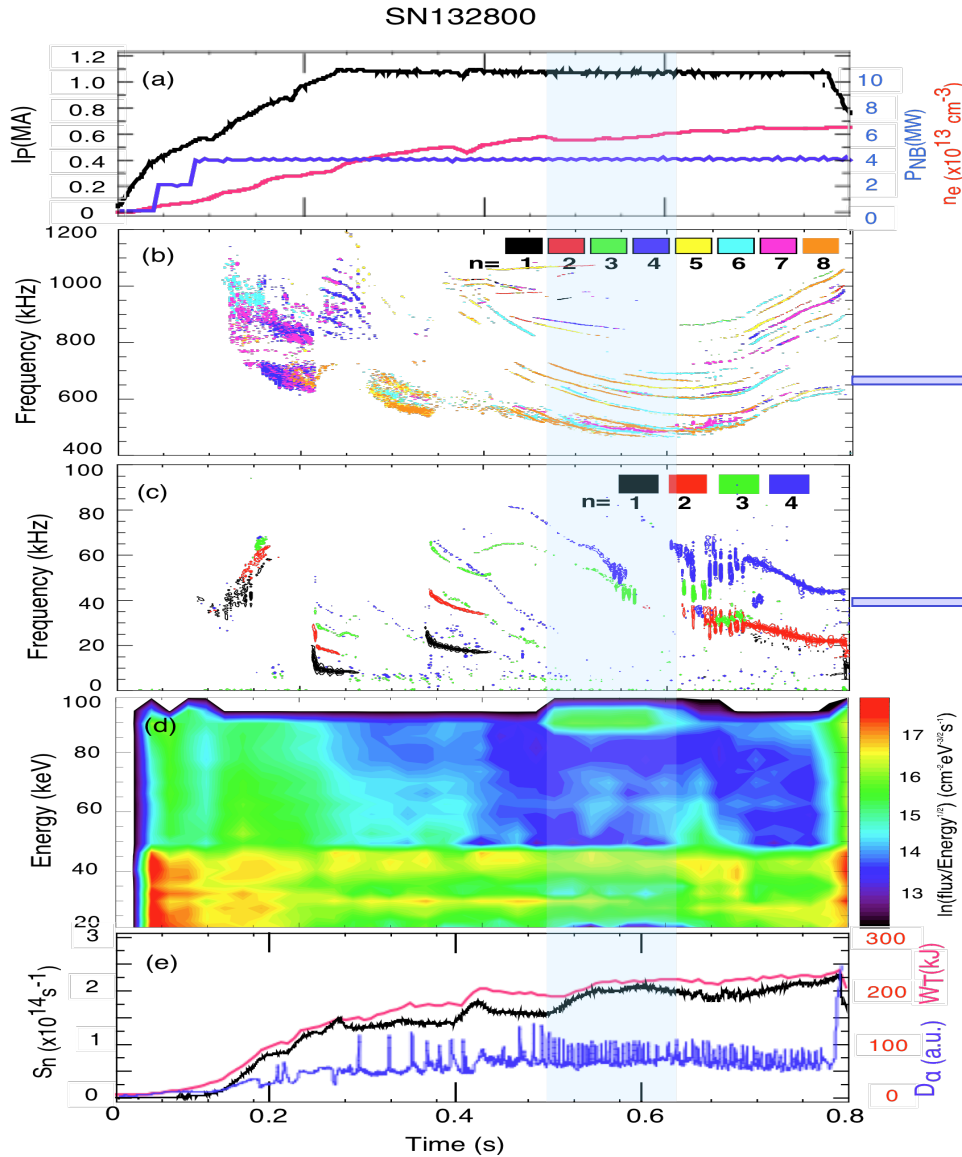
HEF: a strong increase ($\sim 4x$) in the EIBB NPA flux localized around the NB full energy



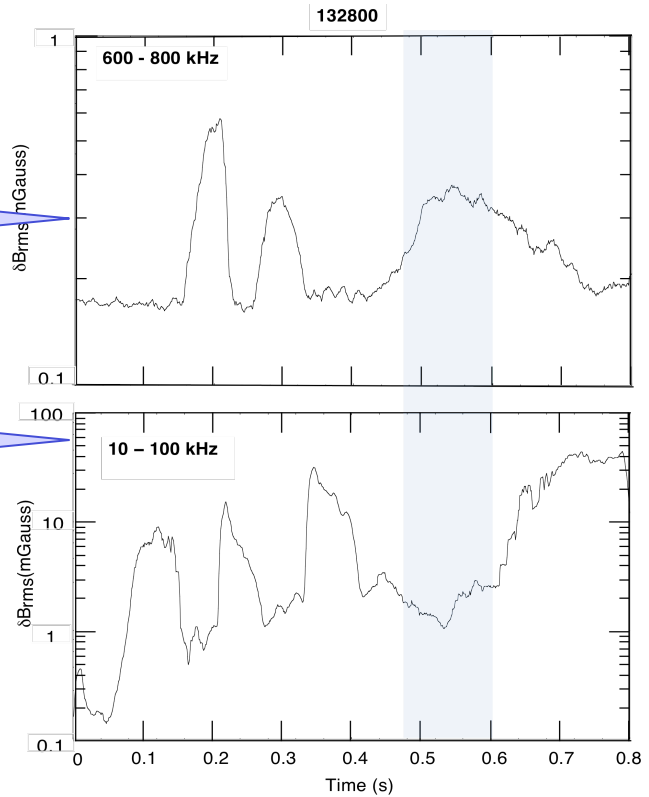
• H-mode with $I_p = 1.1$ MA, $B_T = 4.5$ kG, A&C @ 90 keV, $P_{NB} = 4$ MW, $n_e L \sim 6 \times 10^{13}$ cm^{-2}

Discharge Data and Mirnov δB_{rms} Evolution SN132800

HEFs occur during a period that is kink-free with reduced TAE and robust CAE/GAE



- HEFs have been observed **only in H-mode discharges**: never in L-modes.



- HEFs have been observed **in piggy-back mode** for $I_p = 0.8-1.2$ MA, $B_T = 4.5-5.5$ kG, NPA $R_{tan} = 60-90$ cm, $P_b \geq 4$ MW.

XP for Investigation of the High-Energy Feature (HEF)

Total ~ 12 Shots

- Investigate HEF dependence on NB energy, E_b
 - E_b scan with ABC @ 90, 75, 60 keV (Fiducial + 2 shots)
- Investigate HEF occurrence with NB sources @ mixed E_b
 - A @ 90 keV, B@ 75 keV, C@60 keV (1 shot)
- Investigate HEF on/off transition behavior
 - A + BC notch, B + AC notch, C + AB notch, 60 ms notch (3 shots)
- Investigate HEF spatial and pitch dependencies
 - NPA horizontal scan at optimal E_b (6 shots)
- Special run requirements
 - minimal Lithium as needed for machine conditioning (e.g. < 30 mg/shot, no LLD)
 - MHD mode structure diagnostics (BES, Reflectometry, High-k Scattering, FIRE TIP)
 - desire t-FIDA operational